

**Notice of References Cited**

Application/Control No.

09/499,633

Applicant(s)/Patent Under  
Reexamination  
CHO ET AL.

Examiner

Bradley B. Bayat

Art Unit

3621

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,868,404	03-2005	Ono et al.	705/55
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 01/93002 A2	12-2001	United States	ZAHARRIS et al.	705/51
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	R					
	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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